

STP40NF10

N-channel 100 V, 0.025 Ω 50 A TO-220 low gate charge STripFET™ II Power MOSFET

Features

Order code	V _{DSS}	R _{DS(on)} max.	I _D
STP40NF10	100 V	< 0.028 Ω	50 A

- Exceptional dv/dt capability
- Low gate charge
- 100% avalanche tested

Application

Switching applications

Description

This N-channel 100 V Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps allowing remarkable manufacturing reproducibility.

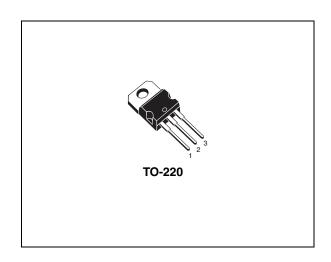


Figure 1. Internal schematic diagram

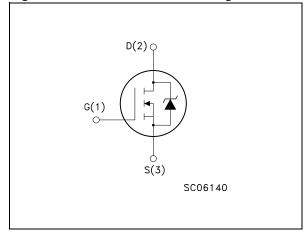


Table 1. Device summary

Order code	Marking	Package	Packaging
STP40NF10	P40NF10@	TO-220	Tube

Contents STP40NF10

Contents

1	Electrical ratings	. 3
2	Electrical characteristics	. 4
	2.1 Electrical characteristics (curves)	6
3	Test circuit	8
4	Package mechanical data	9
5	Revision history	11

STP40NF10 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	100	V
V _{GS}	Gate- source voltage	±20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	50	Α
I _D	Drain current (continuous) at T _C = 100 °C	35	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	200	Α
P _{TOT}	Total dissipation at T _C = 25 °C	150	
	Derating factor	1	W/°C
dv/dt ⁽³⁾	Peak diode recovery voltage slope	27	V/ns
E _{AS} (4)	Single pulse avalanche energy	385	mJ
T _{stg}	Storage temperature	- 55 to 175	
T _j	Max. operating junction temperature	- 55 (0 175	°C

^{1.} Limited by wire bonding

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	1	°C/W
R _{thj-a}	Thermal resistance junction-ambient max	62.5	°C/W
T _I	Maximum lead temperature for soldering purpose	300	°C

^{2.} Pulse width limited by safe operating area

^{3.} $I_{SD} \leq 50$ A, di/dt ≤ 600 A/ μ s, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$.

^{4.} Starting T_i = 25 °C, I_D = 50 A, V_{DD} =25 V

Electrical characteristics STP40NF10

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown voltage	$I_D = 250 \mu A, V_{GS} = 0$	100			V
	Zero gate voltage	V _{DS} = Max rating			1	μΑ
I _{DSS}	Drain current (V _{GS} = 0)	V _{DS} =Max rating,T _C =125°C			10	μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ±20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	٧
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 25 A		0.025	0.028	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15 V _, I _D =28 A	-	22		S
C _{iss}	Input capacitance			2180		pF
C _{oss}	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$	-	298		pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0		83.7		рF
Q_g	Total gate charge	V _{DD} = 50 V, I _D = 40 A,		46.5	62	nC
Q_{gs}	Gate-source charge	$V_{DD} = 50 \text{ V}, I_D = 40 \text{ A},$ $V_{GS} = 10 \text{ V}$	-	13.3		nC
Q_{gd}	Gate-drain charge	(see Figure 15)		17.5	22.5	nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5.

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time Rise time	$V_{DD} = 50V, I_D = 25A$ $R_G = 4.7\Omega V_{GS} = 10V$	1	21 46	1	ns ns
t _{d(off)}	Turn-off-delay time Fall time	(see Figure 14)	ı	54 13	ı	ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current		-		80	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		320	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 50A, V _{GS} = 0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 50A, V_{DD} = 25V di/dt = 100A/ μ s, T_j = 150°C (see Figure 16)	•	80 250 6.4		ns nC A

^{1.} Pulse width limited by safe operating area.

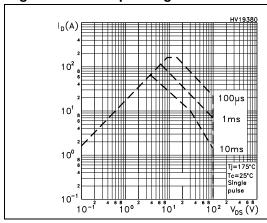
^{2.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STP40NF10

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220

Figure 3. Thermal impedance for TO-220



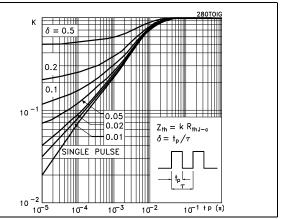
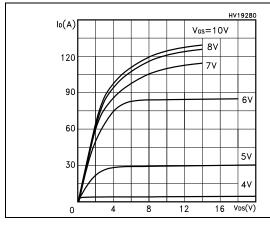


Figure 4. Output characteristics

Figure 5. Transfer characteristics



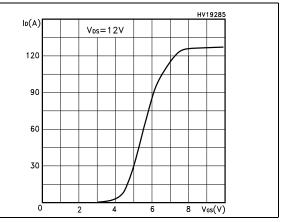
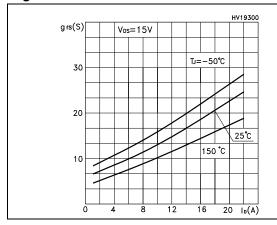
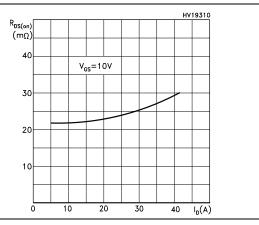


Figure 6. Transconductance

Figure 7. Static drain-source on resistance





| Nos | Nos

Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs. temperature

30

40

50 Qg(nC)

20

10

Figure 11. Normalized on resistance vs. temperature

20

30

40 V_{DS}(V)

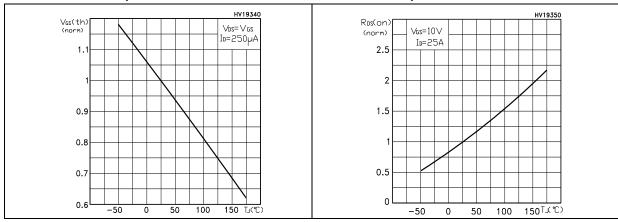
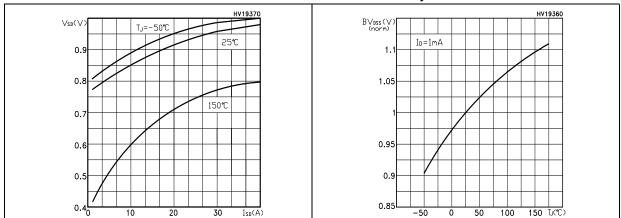


Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized breakdown voltage vs. Tj



Test circuit STP40NF10

3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

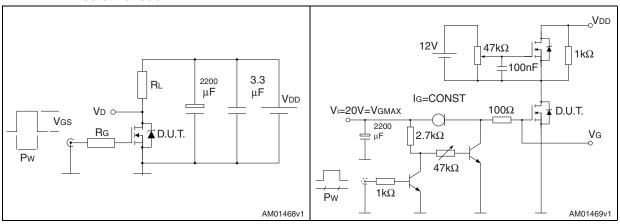


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped Inductive load test circuit

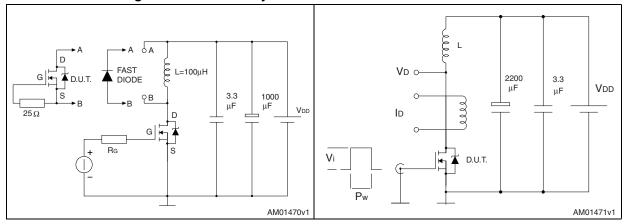
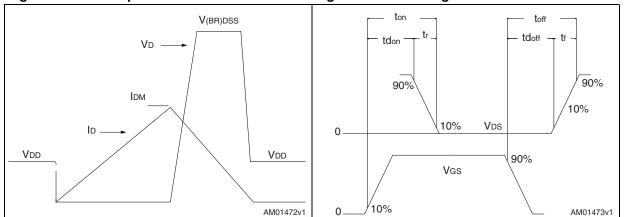


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform

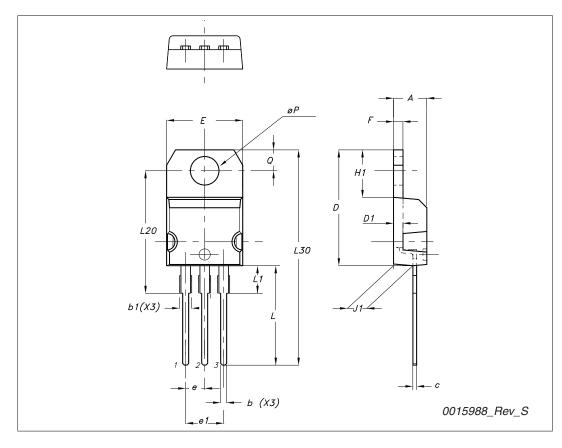


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

TO-220 type A mechanical data

Dim		mm	
Dim	Min	Тур	Max
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95



STP40NF10 Revision history

5 Revision history

Table 8. Document revision history

Date	Revision	Changes
16-Dec-2004	1	First version.
17-Aug-2006	2	The document has been reformatted.
31-Jan-2007	3	Typo mistake on <i>Table 2</i> .
19-Sep-2007	4	Added DPAK.
10-Nov-2010	5	Removed DPAK.

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